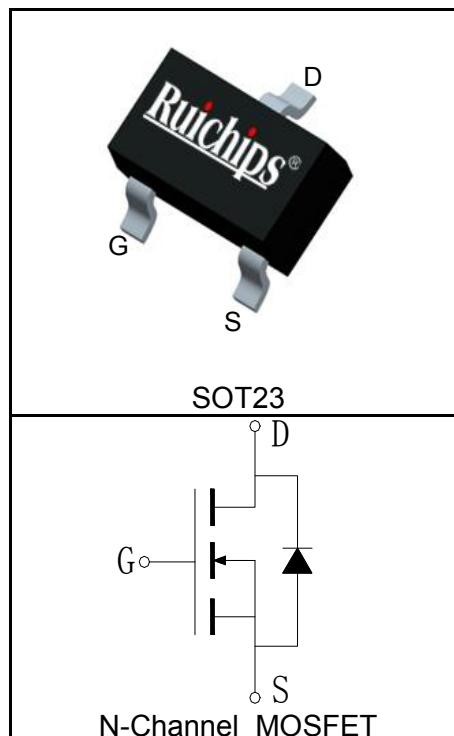


Features

- 30V/6A,
- $R_{DS(ON)} = 26m\Omega$ (Typ.)@ $V_{GS}=10V$
- $R_{DS(ON)} = 30m\Omega$ (Typ.)@ $V_{GS}=4.5V$
- Super High Dense Cell Design
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

Pin Description



Applications

- DC/DC Converter
- Battery Switch

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
Common Ratings ($T_A=25^\circ C$ Unless Otherwise Noted)			
V_{DSS}	Drain-Source Voltage	30	V
V_{GSS}	Gate-Source Voltage	± 16	
T_J	Maximum Junction Temperature	150	°C
T_{STG}	Storage Temperature Range	-55 to 150	°C
I_S	Diode Continuous Forward Current	$T_A=25^\circ C$	1
Mounted on Large Heat Sink			
$I_{DP}^{①}$	300μs Pulse Drain Current Tested	$T_A=25^\circ C$	24
$I_D^{②}$	Continuous Drain Current($V_{GS}=10V$)	$T_A=25^\circ C$	6
		$T_A=70^\circ C$	4.9
P_D	Maximum Power Dissipation	$T_A=25^\circ C$	1.3
		$T_A=70^\circ C$	0.8
$R_{θJC}$	Thermal Resistance-Junction to Case	-	°C/W
$R_{θJA}^{③}$	Thermal Resistance-Junction to Ambient	125	°C/W
Drain-Source Avalanche Ratings			
$E_{AS}^{④}$	Avalanche Energy, Single Pulsed	TBD	mJ

Electrical Characteristics ($T_A=25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Condition	RU3400B			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_{\text{DS}}=250\mu\text{A}$	30			V
I_{DSS}	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=30\text{V}, \text{V}_{\text{GS}}=0\text{V}$		1		μA
		$\text{T}_J=125^\circ\text{C}$			30	
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{DS}}=250\mu\text{A}$	0.5		1.5	V
I_{GSS}	Gate Leakage Current	$\text{V}_{\text{GS}}=\pm 16\text{V}, \text{V}_{\text{DS}}=0\text{V}$			± 100	nA
$\text{R}_{\text{DS}(\text{ON})}^{(5)}$	Drain-Source On-state Resistance	$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_{\text{DS}}=5\text{A}$		30	35	m Ω
		$\text{V}_{\text{GS}}=10\text{V}, \text{I}_{\text{DS}}=6\text{A}$		26	32	m Ω
Diode Characteristics						
$\text{V}_{\text{SD}}^{(5)}$	Diode Forward Voltage	$\text{I}_{\text{SD}}=1\text{A}, \text{V}_{\text{GS}}=0\text{V}$			1.2	V
t_{rr}	Reverse Recovery Time	$\text{I}_{\text{SD}}=6\text{A}, \frac{d\text{I}_{\text{SD}}}{dt}=100\text{A}/\mu\text{s}$		23		ns
Q_{rr}	Reverse Recovery Charge			17		nC
Dynamic Characteristics ⁽⁶⁾						
R_G	Gate Resistance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=0\text{V}, \text{F}=1\text{MHz}$		1.5		Ω
C_{iss}	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{Frequency}=1.0\text{MHz}$		610		pF
C_{oss}	Output Capacitance			65		
C_{rss}	Reverse Transfer Capacitance			45		
$\text{t}_{\text{d}(\text{ON})}$	Turn-on Delay Time	$\text{V}_{\text{DD}}=15\text{V}, \text{I}_{\text{DS}}=6\text{A}, \text{V}_{\text{GEN}}=10\text{V}, \text{R}_G=1\Omega$		3		ns
t_r	Turn-on Rise Time			7		
$\text{t}_{\text{d}(\text{OFF})}$	Turn-off Delay Time			17		
t_f	Turn-off Fall Time			8		
Gate Charge Characteristics ⁽⁶⁾						
Q_g	Total Gate Charge	$\text{V}_{\text{DS}}=24\text{V}, \text{V}_{\text{GS}}=10\text{V}, \text{I}_{\text{DS}}=6\text{A}$		6.5		nC
Q_{gs}	Gate-Source Charge			1.3		
Q_{gd}	Gate-Drain Charge			2.3		

Notes: (1)Pulse width limited by safe operating area.

(2)Calculated continuous current based on maximum allowable junction temperature.

(3)When mounted on 1 inch square copper board, $t \leq 10\text{sec}$. The value in any given application depends on the user's specific board design.

(4)Limited by T_{Jmax} . Starting $\text{T}_J = 25^\circ\text{C}$.

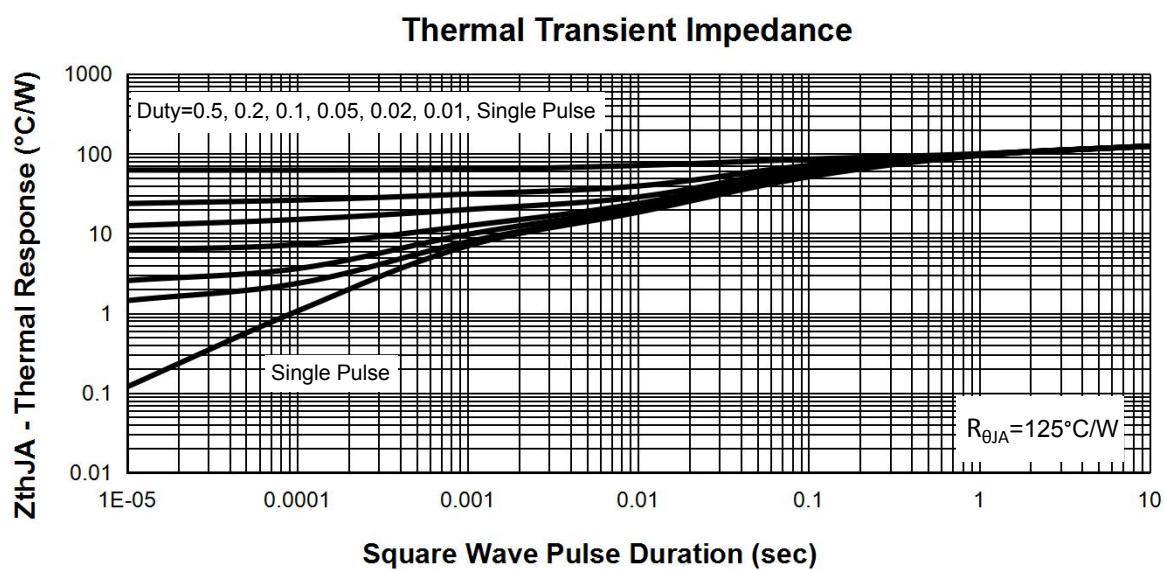
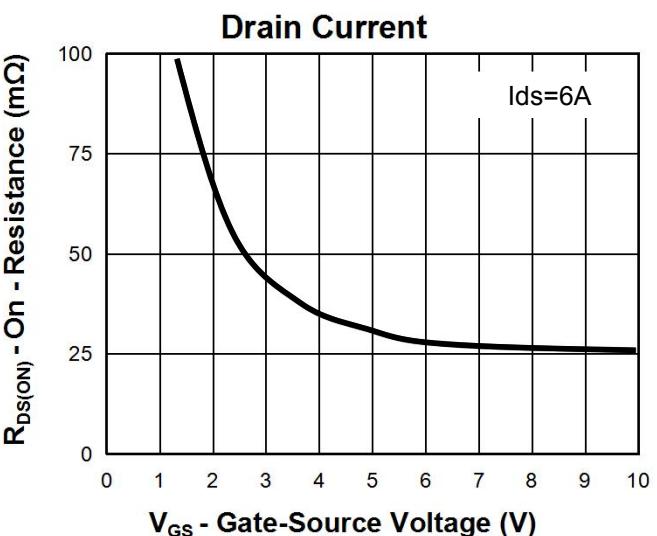
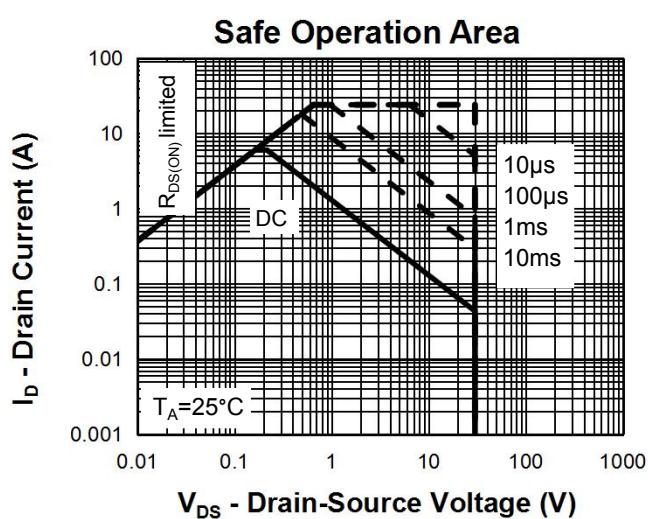
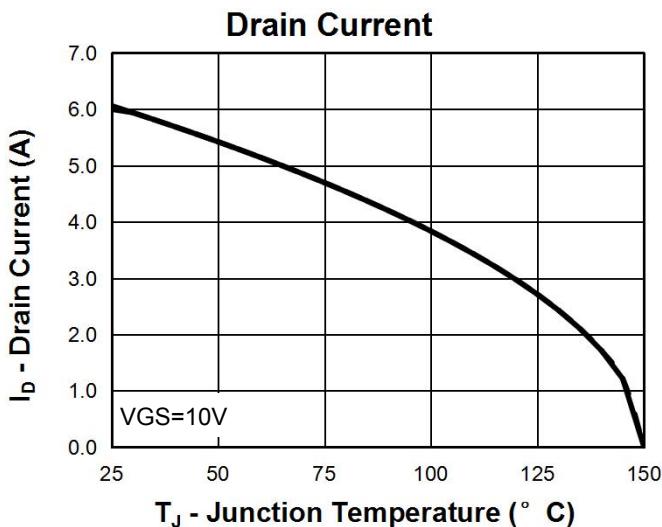
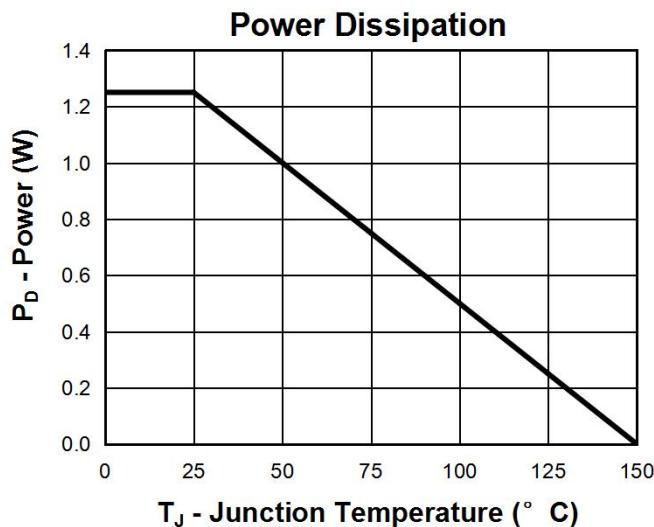
(5)Pulse test; Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

(6)Guaranteed by design, not subject to production testing.

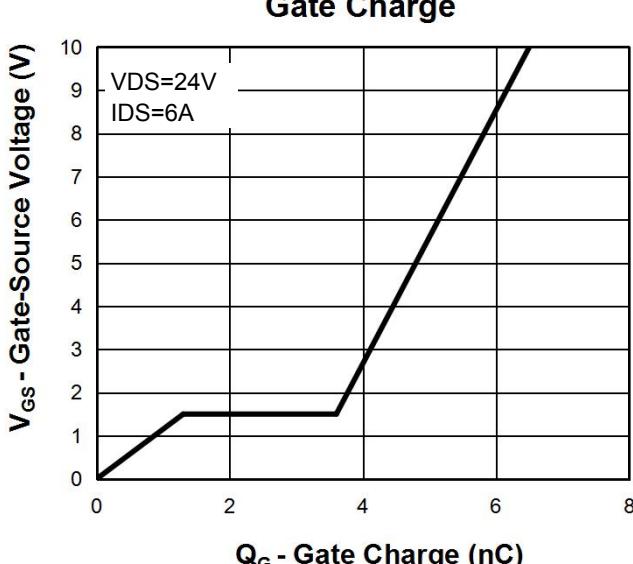
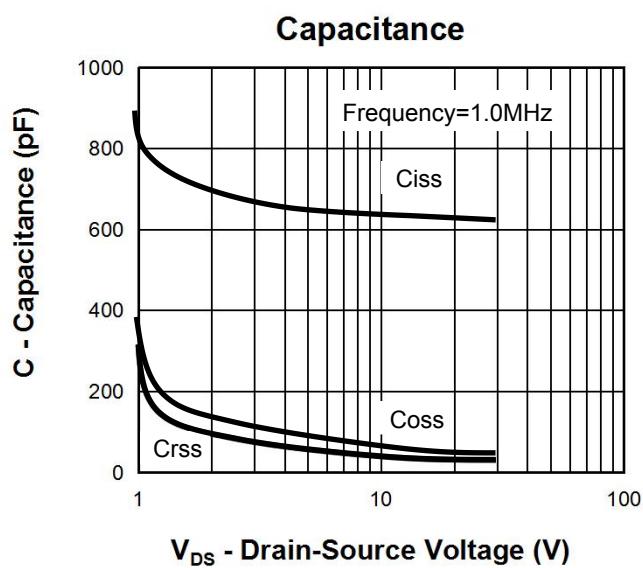
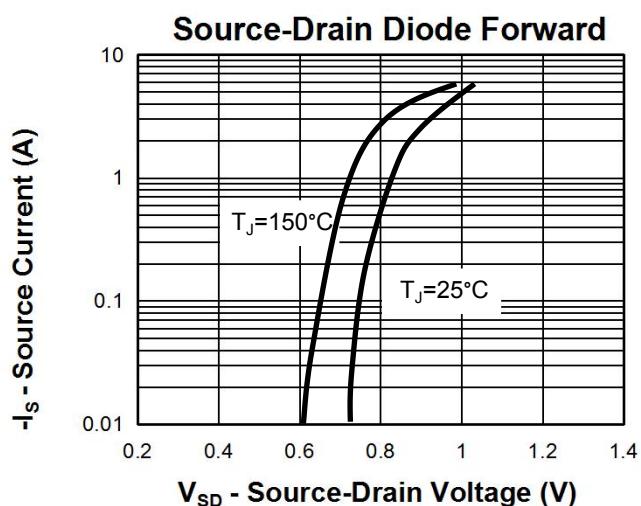
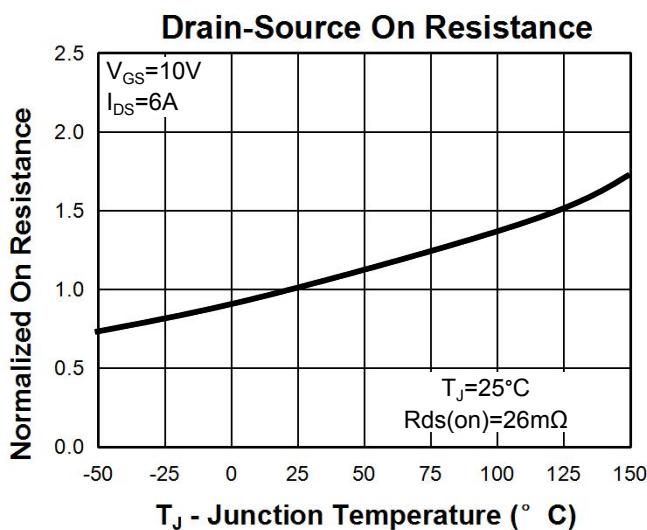
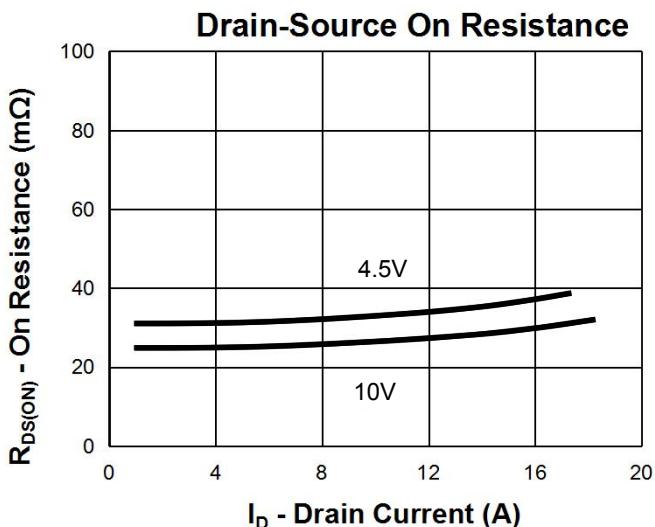
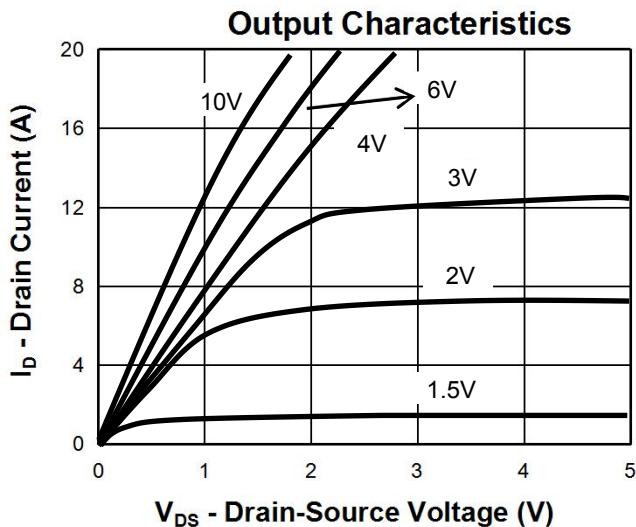
Ordering and Marking Information

Device	Marking	Package	Packaging	Quantity	Reel Size	Tape width
RU3400B	RU3400	SOT23	Tape&Reel	3000	7"	8mm

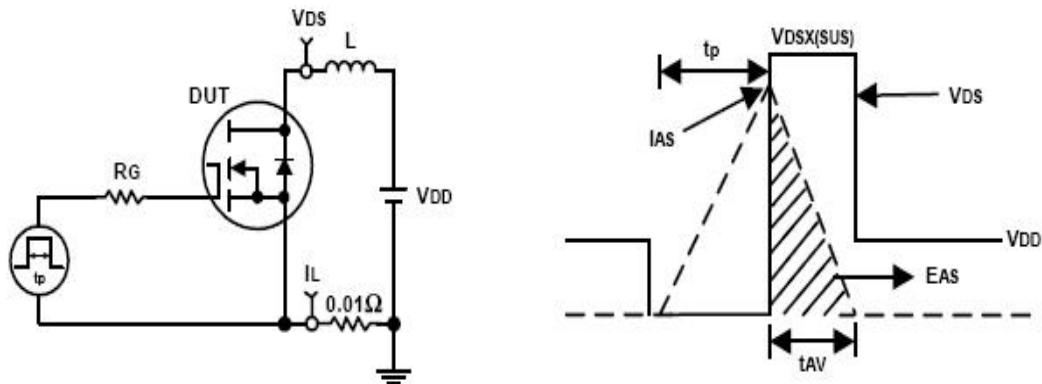
Typical Characteristics



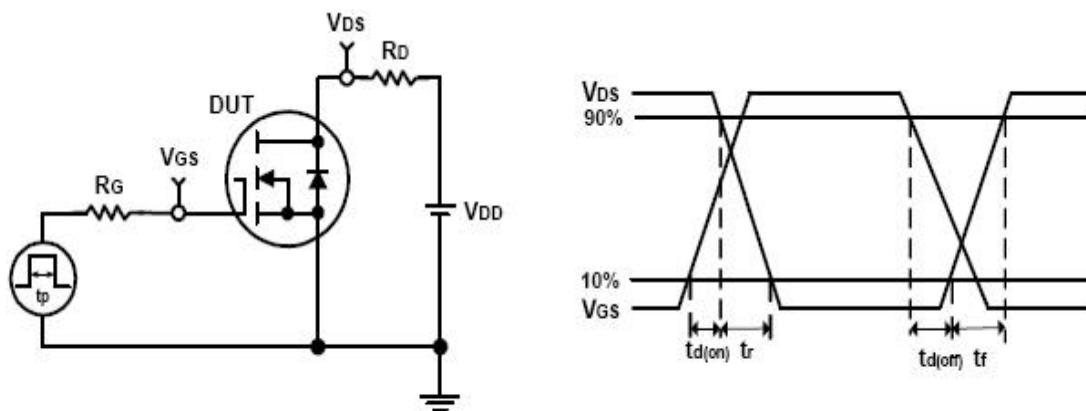
Typical Characteristics



Avalanche Test Circuit and Waveforms

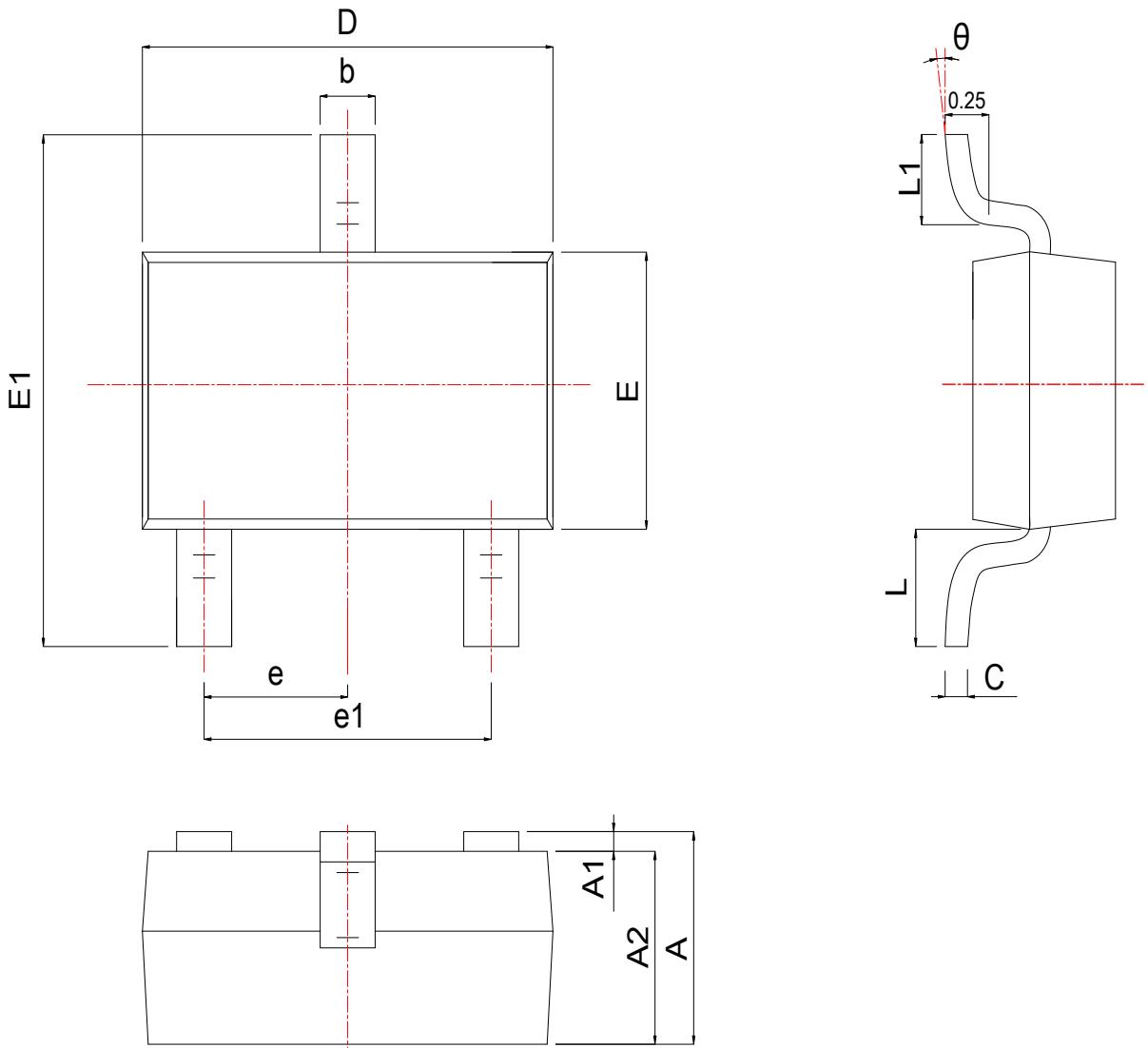


Switching Time Test Circuit and Waveforms



Package Information

SOT23



SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.900	1.025	1.150	0.035	0.040	0.045
A1	0.050	0.075	0.100	0.002	0.003	0.004
A2	0.900	0.975	1.020	0.035	0.038	0.040
b	0.300	0.400	0.500	0.012	0.016	0.020
c	0.080	0.115	0.150	0.003	0.005	0.006
D	2.800	2.900	3.000	0.110	0.114	0.118
E	1.200	1.300	1.400	0.047	0.051	0.055
E1	2.250	2.400	2.550	0.089	0.094	0.100
e	0.950 TYP			0.037 TYP		
e1	1.800	1.900	2.000	0.071	0.075	0.079
L	0.540 REF			0.021 REF		
L1	0.400	0.500	0.600	0.016	0.018	0.020
theta	0°	*	8°	0°	*	8°

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